

## SEMITRANS® 3

### **IGBT4** Modules

#### SKM400GM17E4

#### Features\*

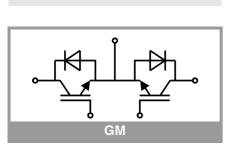
- IGBT4 = 4th generation medium fast trench IGBT (Infineon)
- CAL4 = Soft switching 4th generation CAL-Diode
- Insulated copper baseplate using DBC Technology (Direct Copper Bonding)
- With integrated Gate resistor
- For switching frequencies up to 8kHz
- UL recognized, file no. E63532

### **Typical Applications**

- · Matrix Inverter
- · Bidirectional switch

#### Remarks

- Case temperature limited to  $T_c = 125$ °C max.
- Recommended  $T_{op} = -40 \dots +150$ °C
- Product reliability results valid for  $T_i = 150$ °C



Absolute	Maximum Ratin	gs		
Symbol	Conditions		Values	Unit
IGBT	•			•
V <sub>CES</sub>	T <sub>j</sub> = 25 °C		1700	V
Ic	T <sub>i</sub> = 175 °C	T <sub>c</sub> = 25 °C	614	А
	1 1 1 1 1 0	T <sub>c</sub> = 80 °C	474	Α
I <sub>Cnom</sub>			400	А
I <sub>CRM</sub>			1200	Α
$V_{GES}$			-20 20	V
t <sub>psc</sub>	$V_{CC} = 1000 \text{ V}$ $V_{GE} \le 15 \text{ V}$ $V_{CES} \le 1700 \text{ V}$	T <sub>j</sub> = 150 °C	10	μs
Tj			-40 175	°C
Inverse d	iode			
$V_{RRM}$	T <sub>j</sub> = 25 °C		1700	V
I <sub>F</sub>	T <sub>i</sub> = 175 °C	T <sub>c</sub> = 25 °C	443	Α
	11j = 175 C	T <sub>c</sub> = 80 °C	327	Α
I <sub>FRM</sub>		•	800	Α
I <sub>FSM</sub>	$t_p = 10 \text{ ms, sin } 180^{\circ}, T_j = 25 ^{\circ}\text{C}$		2340	Α
Tj			-40 175	°C
Module		_		•
I <sub>t(RMS)</sub>			500	А
T <sub>stg</sub>	module without TIM		-40 125	°C
V <sub>isol</sub>	AC sinus 50 Hz, t = 1 min		4000	V

Characteristics							
Symbol	Conditions		min.	typ.	max.	Unit	
IGBT							
V <sub>CE(sat)</sub>	I <sub>C</sub> = 400 A V <sub>GE</sub> = 15 V chiplevel	T <sub>j</sub> = 25 °C		1.92	2.20	V	
		T <sub>j</sub> = 150 °C		2.30	2.60	V	
V <sub>CE0</sub>	chiplevel	T <sub>j</sub> = 25 °C		0.80	0.90	V	
		T <sub>j</sub> = 150 °C		0.70	0.80	V	
r <sub>CE</sub>	V <sub>GE</sub> = 15 V chiplevel	T <sub>j</sub> = 25 °C		2.8	3.3	mΩ	
		T <sub>j</sub> = 150 °C		4.0	4.5	mΩ	
$V_{GE(th)}$	$V_{GE}=V_{CE}$ , $I_{C}=16$ mA		5.2	5.8	6.4	V	
I <sub>CES</sub>	$V_{GE} = 0 \text{ V}, V_{CE} = 17$	00 V, T <sub>j</sub> = 25 °C			5	mA	
C <sub>ies</sub>	V <sub>CE</sub> = 25 V V <sub>GE</sub> = 0 V	f = 1 MHz		36.0		nF	
Coes		f = 1 MHz		1.36		nF	
C <sub>res</sub>		f = 1 MHz		1.16		nF	
$Q_{G}$	V <sub>GE</sub> = - 8 V+ 15 V			3200		nC	
R <sub>Gint</sub>	T <sub>j</sub> = 25 °C			1.9		Ω	
t <sub>d(on)</sub>	V <sub>CC</sub> = 1200 V	T <sub>j</sub> = 150 °C		280		ns	
t <sub>r</sub>	$\begin{array}{l} I_{C} = 400 \text{ A} \\ V_{GE} = +15/\text{-}15 \text{ V} \\ R_{G \text{ on}} = 2 \Omega \\ R_{G \text{ off}} = 1 \Omega \\ di/dt_{on} = 10000 \text{ A/} \\ \mu s \\ di/dt_{off} = 2300 \text{ A/} \mu s \\ dv/dt = 5600 \text{ V/} \mu s \end{array}$	T <sub>j</sub> = 150 °C		45		ns	
Eon		T <sub>j</sub> = 150 °C		157		mJ	
t <sub>d(off)</sub>		T <sub>j</sub> = 150 °C		760		ns	
t <sub>f</sub>		T <sub>j</sub> = 150 °C		140		ns	
E <sub>off</sub>		T <sub>j</sub> = 150 °C		180		mJ	
R <sub>th(j-c)</sub>	per IGBT				0.066	K/W	
R <sub>th(c-s)</sub>	per IGBT (λ <sub>grease</sub> =0	.81 W/(m*K))		0.028		K/W	
R <sub>th(c-s)</sub>	per IGBT, pre-applied phase change material			0.017		K/W	



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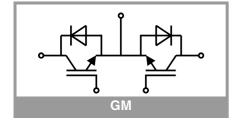
Remarks

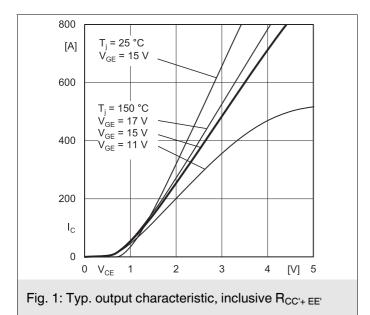
• Case temperature limited to  $T_c = 125^{\circ}C$  max.

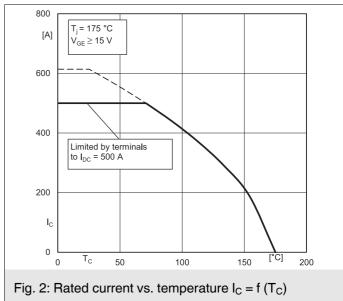
• Recommended  $T_{op} = -40 \dots +150$ °C

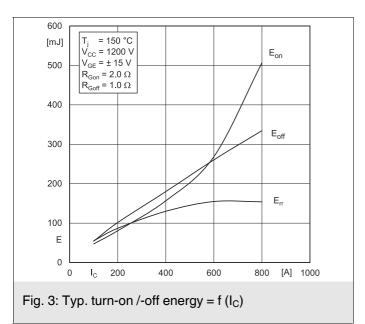
• Product reliability results valid for  $T_i = 150$ °C

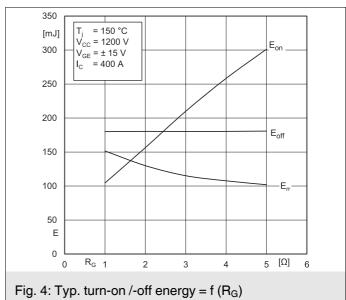
Characteristics								
Symbol	Conditions	min.	typ.	max.	Unit			
Inverse diode								
$V_F = V_{EC}$	I <sub>F</sub> = 400 A	T <sub>j</sub> = 25 °C		2.00	2.40	V		
	V <sub>GE</sub> = 0 V chiplevel	T <sub>j</sub> = 150 °C		2.16	2.57	V		
$V_{F0}$	ohinlovol	T <sub>j</sub> = 25 °C		1.32	1.56	V		
chiplevel	Criipievei	T <sub>j</sub> = 150 °C		1.08	1.22	V		
r <sub>F</sub>	chiplevel	T <sub>j</sub> = 25 °C		1.71	2.1	mΩ		
		T <sub>j</sub> = 150 °C		2.7	3.4	mΩ		
I <sub>RRM</sub>	I <sub>F</sub> = 400 A	T <sub>j</sub> = 150 °C		615		Α		
Q <sub>rr</sub>	di/dt <sub>off</sub> = 10100 A/ µs	T <sub>j</sub> = 150 °C		150		μC		
E <sub>rr</sub>	V <sub>GE</sub> = -15 V V <sub>CC</sub> = 1200 V	T <sub>j</sub> = 150 °C		130		mJ		
R <sub>th(j-c)</sub>	per diode			0.13	K/W			
R <sub>th(c-s)</sub>	per diode (λ <sub>grease</sub> =0		0.038		K/W			
R <sub>th(c-s)</sub>	per diode, pre-applied phase change material			0.032		K/W		
Module								
L <sub>CE</sub>				15		nΗ		
R <sub>CC'+EE'</sub>	measured per	T <sub>C</sub> = 25 °C		0.55		mΩ		
	switch	T <sub>C</sub> = 125 °C		0.85		mΩ		
R <sub>th(c-s)1</sub>	calculated without thermal coupling			0.0081		K/W		
R <sub>th(c-s)2</sub>	including thermal c $T_s$ underneath mod $(\lambda_{grease}=0.81 \text{ W/(m}^3))$		0.013		K/W			
R <sub>th(c-s)2</sub>	including thermal coupling, T <sub>s</sub> underneath module, pre-applied phase change material			0.009		K/W		
Ms	to heat sink M6		3		5	Nm		
$M_{t}$		to terminals M6	2.5		5	Nm		
						Nm		
W					325	g		

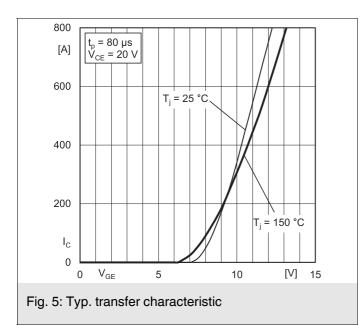


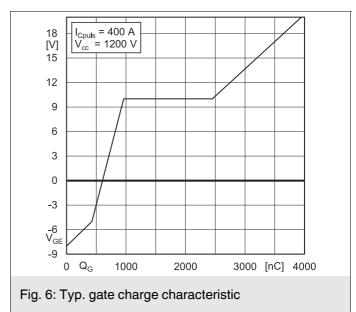


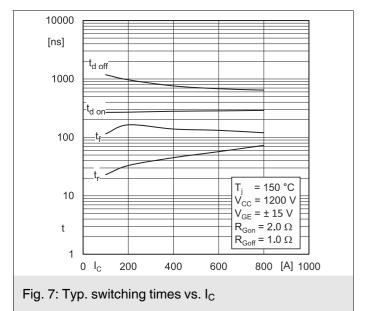


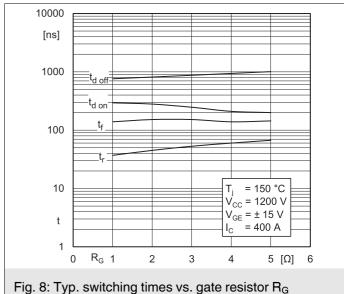


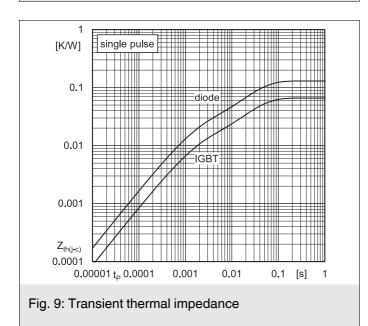


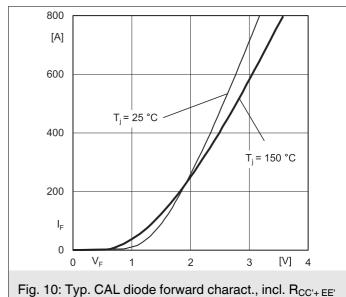


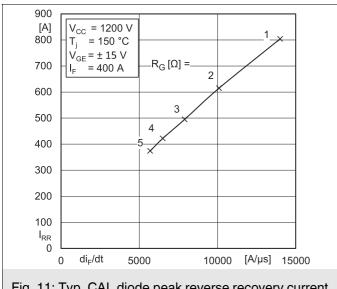












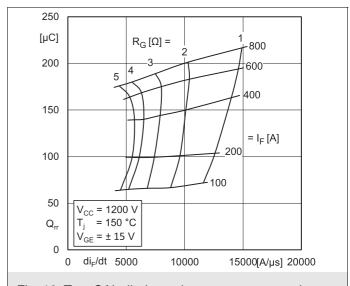
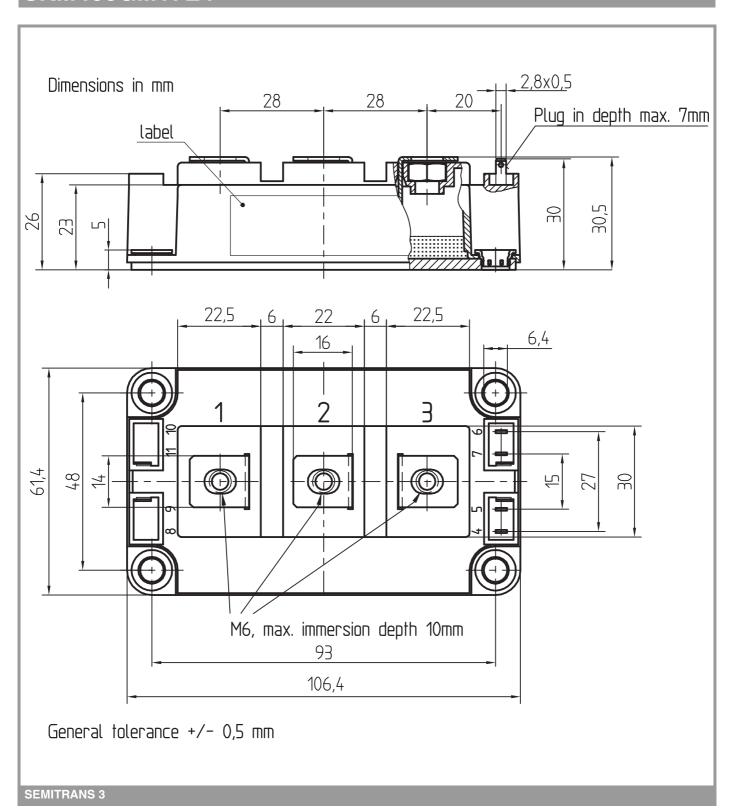
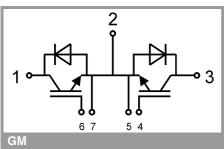


Fig. 11: Typ. CAL diode peak reverse recovery current





This is an electrostatic discharge sensitive device (ESDS) due to international standard IEC 61340.

#### \*IMPORTANT INFORMATION AND WARNINGS

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